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# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









# AON6290

# 100V N-Channel MOSFET

# **General Description**

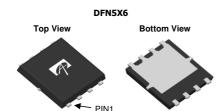
The AON6290 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{\rm DS(ON)},$  Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

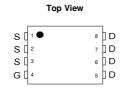
# **Product Summary**

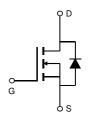
 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 85A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 4.6 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 6V) & < 6.2 m\Omega \end{array}$ 

100% UIS Tested 100%  $R_g$  Tested









Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		$V_{DS}$	100	V			
Gate-Source Voltage		$V_{GS}$	±20	V			
Continuous Drain	T <sub>C</sub> =25℃	1	85				
Current G	T <sub>C</sub> =100℃	I <sub>D</sub>	67	Α			
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	120				
Continuous Drain Current	T <sub>A</sub> =25℃	1	28	A			
	T <sub>A</sub> =70℃	IDSM	23	^			
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	60	Α			
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub>	180	mJ			
Power Dissipation <sup>B</sup>	T <sub>C</sub> =25℃	P <sub>D</sub>	104	W			
	T <sub>C</sub> =100℃	- D	42	VV			
	T <sub>A</sub> =25℃	Р	7.3	W			
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70℃	P <sub>DSM</sub>	4.7	VV			
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	14	17	€/M			
Maximum Junction-to-Ambient AD	Steady-State	П <sub>Ө</sub> ЈА	40	55	€/M			
Maximum Junction-to-Case Steady-State		$R_{\theta JC}$	1	1.2	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units			
STATIC PARAMETERS									
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	100			V			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V			1	μΑ			
	Oak Ball Indiana and	T <sub>J</sub> =55℃			5				
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	2.2	2.8	3.4	V			
I <sub>D(ON)</sub>	On state drain current	$V_{GS}=10V$ , $V_{DS}=5V$	120			Α			
	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		3.8	4.6	mΩ			
$R_{DS(ON)}$		T <sub>J</sub> =125℃		6.5	7.9				
		$V_{GS}=6V$ , $I_D=20A$		4.7	6.2	mΩ			
g <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V$ , $I_{D}=20A$		70		S			
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.7	1	V			
$I_S$	Maximum Body-Diode Continuous Curr			85	Α				
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance			4600		pF			
Coss	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =50V, f=1MHz		415		pF			
$C_{rss}$	Reverse Transfer Capacitance			27		pF			
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	0.3	0.75	1.2	Ω			
SWITCHI	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge			63	90	nC			
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A		28.5	40	nC			
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A		17		nC			
$Q_{gd}$	Gate Drain Charge			10		nC			
$t_{D(on)}$	Turn-On DelayTime			14.5		ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}=10V, V_{DS}=50V, R_{L}=2.5\Omega,$		5.5		ns			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		37		ns			
t <sub>f</sub>	Turn-Off Fall Time			7.5		ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs		40		ns			
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F$ =20A, dI/dt=500A/ $\mu$ s		230		nC			

A. The value of  $R_{hJA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J/(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>1</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

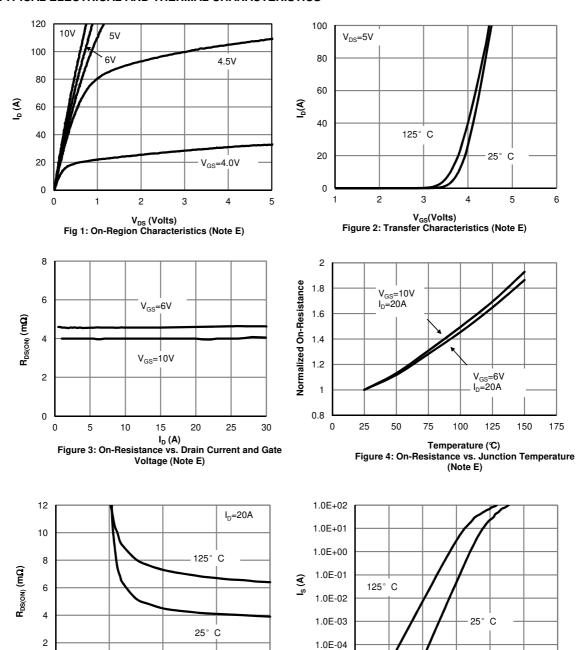
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



0

2

10

V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)

1.0E-05

0.0

0.2

1.0

0.6

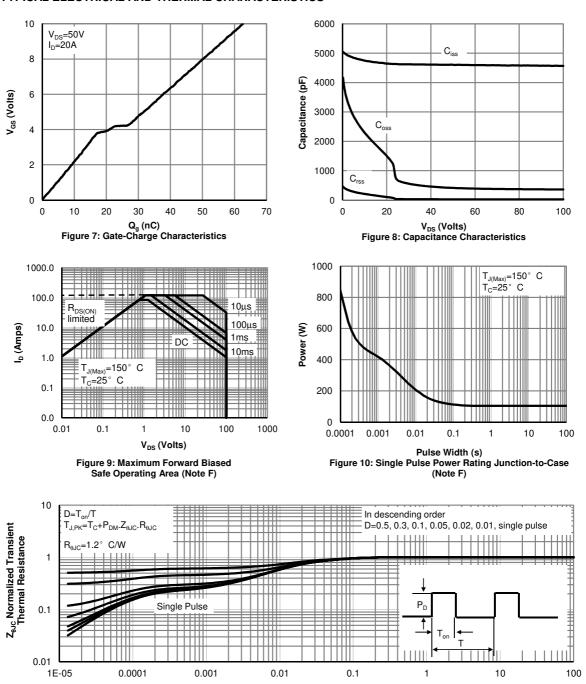
V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)

0.8

1.2



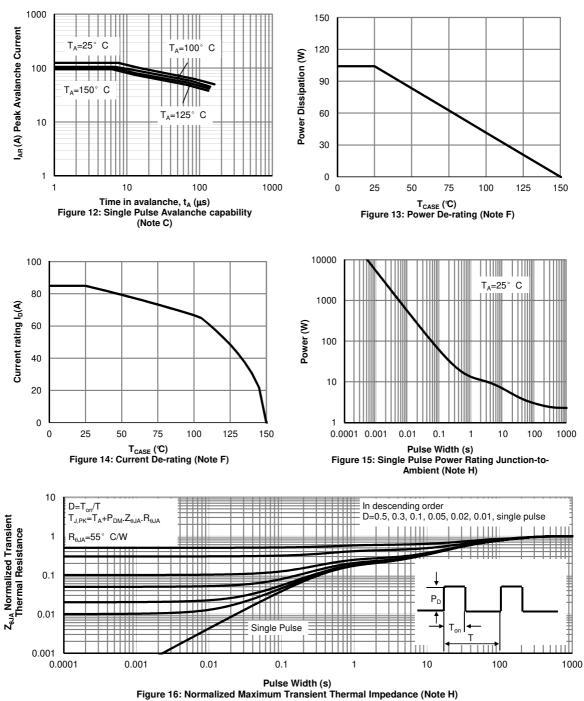
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

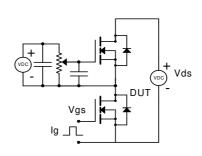


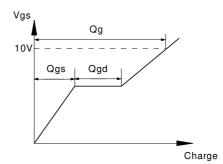
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



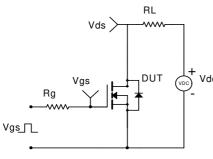


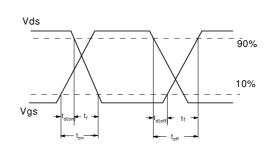
# Gate Charge Test Circuit & Waveform



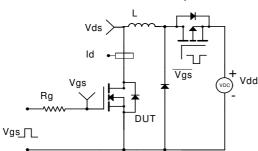


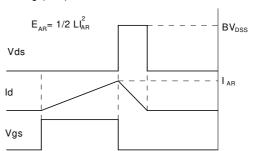
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

